

MOSFET

OptiMOS[™] 3 Power-Transistor, 250 V

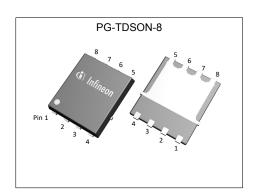
Features

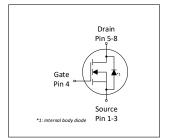
- N-channel, normal level

- Excellent gate charge x R_{DS(on)} product (FOM)
 Very low on-resistance R_{DS(on)}
 Pb-free lead plating; RoHS compliant
 Qualified according to JEDEC¹⁾ for target application
 Halogen-free according to IEC61249-2-21
- Ideal for high-frequency switching and synchronous rectification

Table 1 **Key Performance Parameters**

Parameter	Value	Unit	
V _{DS}	250	V	
R _{DS(on),max}	60	mΩ	
I _D	25	A	











Type / Ordering Code	Package	Marking	Related Links
BSC600N25NS3 G	PG-TDSON-8	600N25NS	-



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1 Maximum ratings at T_A =25 °C, unless otherwise specified

Table 2 **Maximum ratings**

Barramantan	Ob. a.l	Values			11	
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Continuous drain current	I _D	-	-	25 16	А	T _C =25 °C T _C =100 °C
Pulsed drain current ¹⁾	I _{D,pulse}	-	-	100	Α	<i>T</i> _C =25 °C
Avalanche energy, single pulse	E AS	-	-	210	mJ	$I_{\rm D}$ =25 A, $R_{\rm GS}$ =25 Ω
Reverse diode dv/dt	dv/dt	-	-	10	kV/µs	-
Gate source voltage	V _{GS}	-20	-	20	V	-
Power dissipation	P _{tot}	-	-	125	W	<i>T</i> _C =25 °C
Operating and storage temperature	T _j , T _{stg}	-55	-	150	°C	IEC climatic category; DIN IEC 68-1: 55/150/56

2 Thermal characteristics

Table 3 **Thermal characteristics**

Parameter	Cumbal	Values			Unit	Note / Test Condition	
Faranietei	Symbol	Min.	Тур.	Max.	Ullit	Note / Test Condition	
Thermal resistance, junction - case	R _{thJC}	-	-	1	K/W	-	
Thermal resistance, junction - ambient, minimal footprint	R _{thJA}	-	-	75	K/W	-	
Thermal resistance, junction - ambient, 6 cm² cooling area²)	R _{thJA}	-	-	50	K/W	-	

 $^{^{1)}}$ See Diagram 3 $^{2)}$ Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm² (one layer, 70 µm thick) copper area for drain connection. PCB is vertical in still air.



3 Electrical characteristics at T_j =25 °C, unless otherwise specified

Table 4 **Static characteristics**

Barranatan	0		Values			
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Drain-source breakdown voltage	V _{(BR)DSS}	250	-	-	V	V _{GS} =0 V, I _D =1 mA
Gate threshold voltage	V _{GS(th)}	2	3	4	V	V _{DS} =V _{GS} , I _D =90 μA
Zero gate voltage drain current	I _{DSS}	-	0.1 10	1 100	μΑ	V _{DS} =200 V, V _{GS} =0 V, T _j =25 °C V _{DS} =200 V, V _{GS} =0 V, T _j =125 °C
Gate-source leakage current	I_{GSS}	-	1	100	nA	V _{GS} =20 V, V _{DS} =0 V
Drain-source on-state resistance	R _{DS(on)}	-	50	60	mΩ	V _{GS} =10 V, I _D =25 A
Gate resistance	R _G	-	2.5	-	Ω	-
Transconductance	g fs	25	49	-	S	$ V_{DS} > 2 I_D R_{DS(on)max}, I_D = 25 A$

Table 5 **Dynamic characteristics**

Develope	O make at	Values			11!4	
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Input capacitance	C _{iss}	-	1770	2350	pF	V _{GS} =0 V, V _{DS} =100 V, f=1 MHz
Output capacitance	Coss	-	112	149	pF	V _{GS} =0 V, V _{DS} =100 V, f=1 MHz
Reverse transfer capacitance	Crss	-	3	-	pF	V _{GS} =0 V, V _{DS} =100 V, f=1 MHz
Turn-on delay time	$t_{\sf d(on)}$	-	10	-	ns	$V_{\rm DD}$ =100 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =12 A, $R_{\rm G}$ =1.6 Ω
Rise time	t _r	-	10	-	ns	$V_{\rm DD}$ =100 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =12 A, $R_{\rm G}$ =1.6 Ω
Turn-off delay time	$t_{ m d(off)}$	-	22	-	ns	$V_{\rm DD}$ =100 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =12 A, $R_{\rm G}$ =1.6 Ω
Fall time	t _f	-	8	-	ns	$V_{\rm DD}$ =100 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =12 A, $R_{\rm G}$ =1.6 Ω

Table 6 Gate charge characteristics¹⁾

Daramatar	Cumbal	Values			l lmi4	Note / Took Condition
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Gate to source charge	Q _{gs}	-	8	-	nC	V_{DD} =100 V, I_{D} =12 A, V_{GS} =0 to 10 V
Gate to drain charge	Q _{gd}	-	2	-	nC	V_{DD} =100 V, I_{D} =12 A, V_{GS} =0 to 10 V
Switching charge	Q _{sw}	-	5	-	nC	V_{DD} =100 V, I_{D} =12 A, V_{GS} =0 to 10 V
Gate charge total	Qg	-	22	29	nC	V_{DD} =100 V, I_{D} =12 A, V_{GS} =0 to 10 V
Gate plateau voltage	V _{plateau}	-	4.3	-	V	V_{DD} =100 V, I_{D} =12 A, V_{GS} =0 to 10 V
Output charge	Qoss	-	45	60	nC	V _{DD} =100 V, V _{GS} =0 V

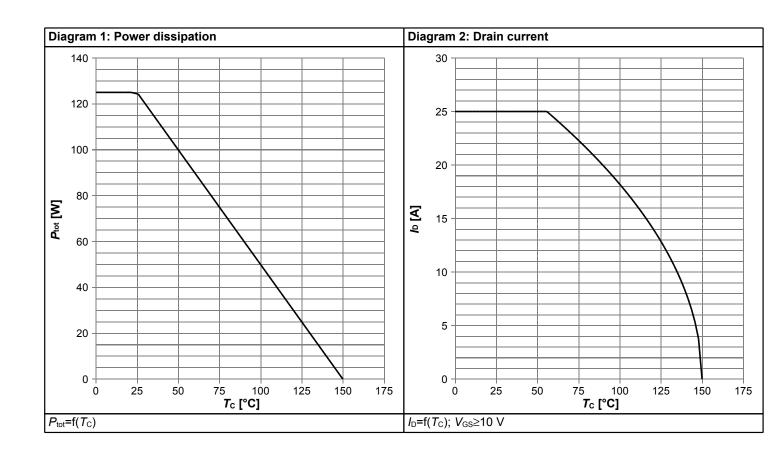


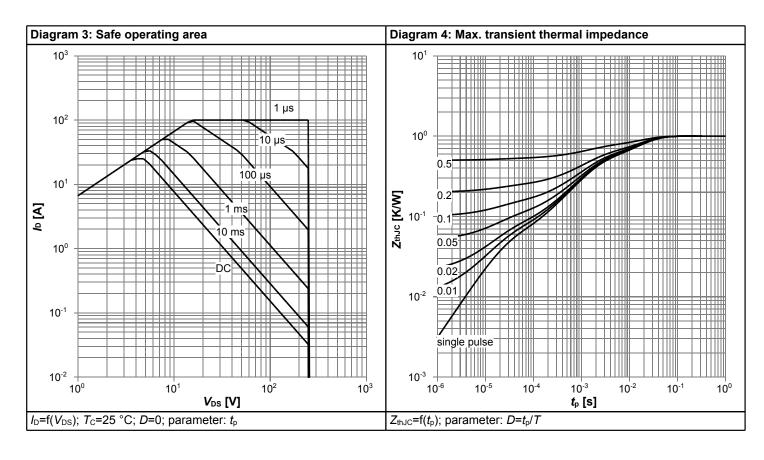
Table 7 Reverse diode

Parameter	Cumbal		Values			Nata / Tast Canditian
	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Diode continous forward current	Is	-	-	25	Α	<i>T</i> _C =25 °C
Diode pulse current	I _{S,pulse}	-	-	100	Α	<i>T</i> _C =25 °C
Diode forward voltage	V _{SD}	-	0.9	1.2	V	V _{GS} =0 V, I _F =25 A, T _j =25 °C
Reverse recovery time	t _{rr}	-	114	-	ns	V_R =125 V, I_F =12 A, di_F/dt =100 A/ μ s
Reverse recovery charge	Qrr	-	700	-	nC	V _R =125 V, I _F =12 A, d <i>i</i> _F /d <i>t</i> =100 A/μs

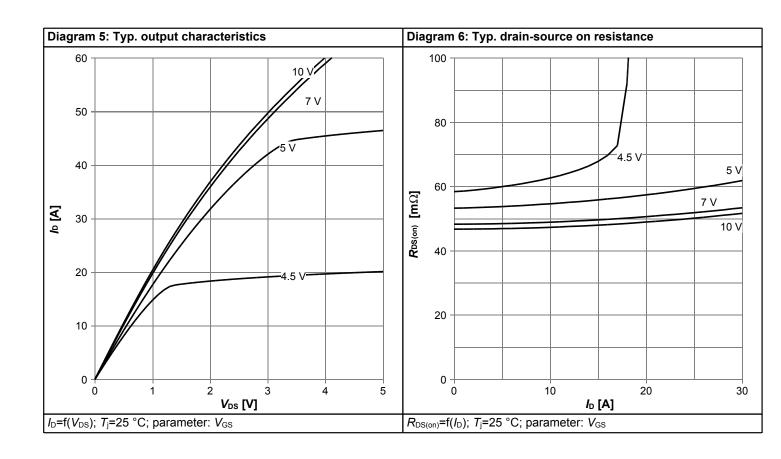


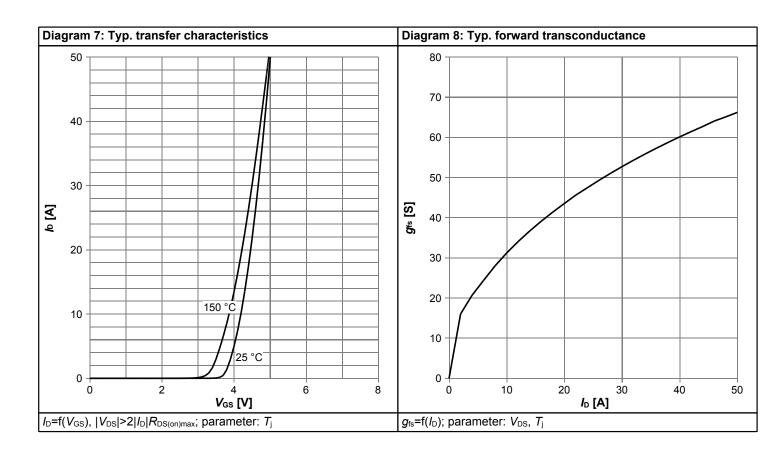
4 Electrical characteristics diagrams



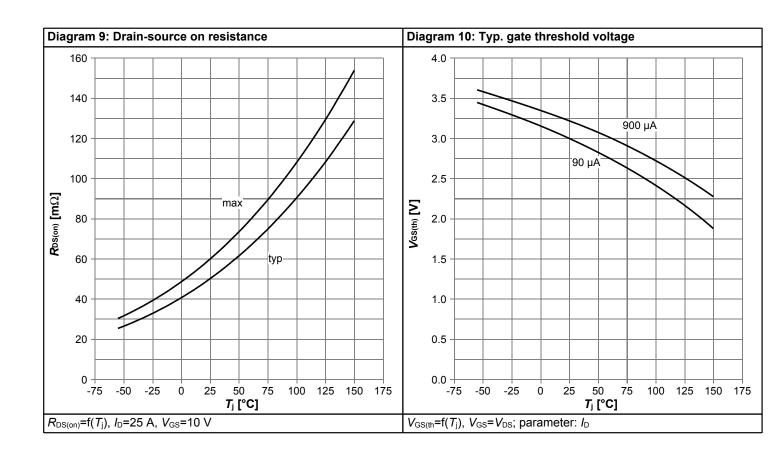


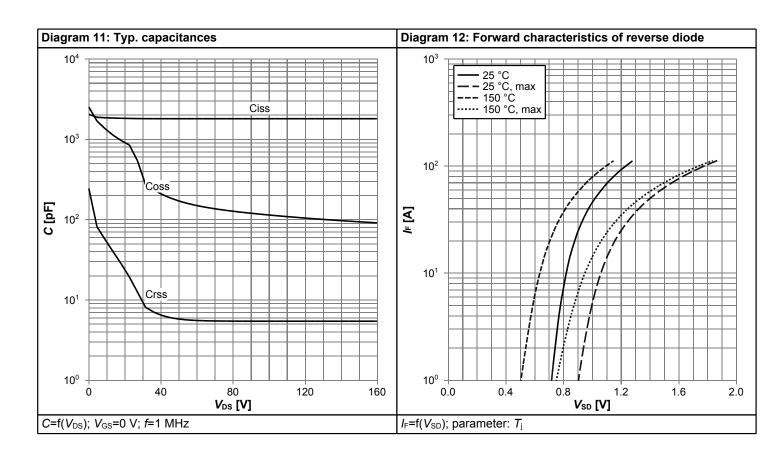




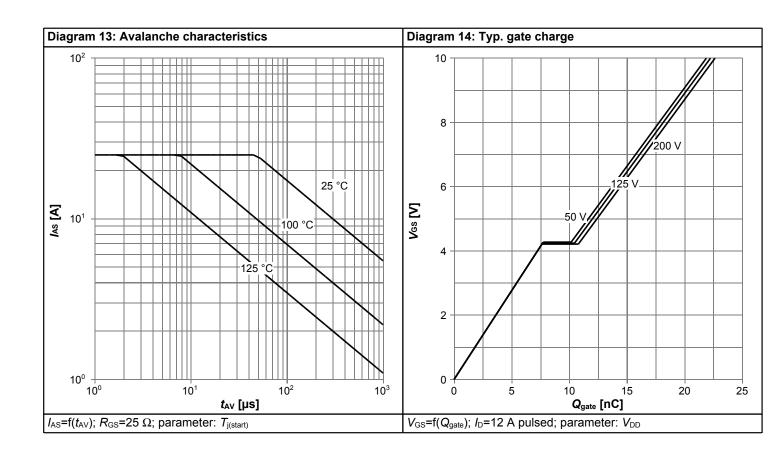


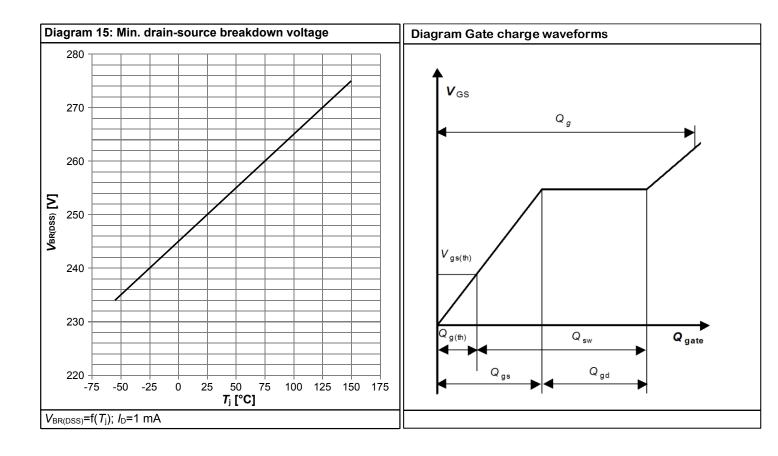






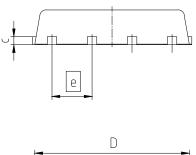


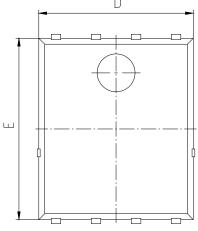


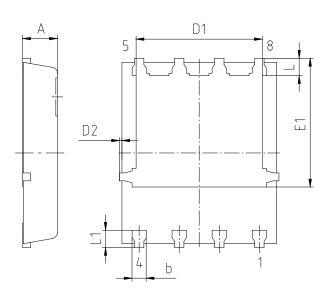




5 Package Outlines







PACKAGE - GROUP NUMBER:	PG-TDS	PG-TDSON-8-U08					
DIMENSIONS	MILLIM	ETERS					
DIMENSIONS	MIN.	MAX.					
Α	0.90	1.20					
b	0.34	0.54					
С	0.15	0.35					
D	4.80	5.35					
D1	3.90	4.40					
D2	0.00	0.22					
E	5.70	6.10					
E1	4.05	4.25					
е	1.27						
L	0.45	0.65					
L1	0.45	0.65					

- 1) EXCLUDING MOLD FLASH
- 2) REMOVAL ON MOLD GATE INTRUSION 0.1 MM PROTRUSION 0.1 MM
- 3) ALL METAL SURFACES ARE PLATED, EXCEPT AREA OF CUT

Figure 1 Outline PG-TDSON-8, dimensions in mm



Revision History

BSC600N25NS3 G

Revision: 2022-11-09, Rev. 2.5

Previous Revision

1 ICVIOUS IV	1 Tevious Nevision						
Revision	Date	Subjects (major changes since last revision)					
2.5	2022-11-09	Update package outline drawing					

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